

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	669	439/169,174,482,912.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:07
L2	0	probe with tri44 adj cable	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:07
L3	0	2 and 1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:07
L4	9	(shield adj probe) near5 test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:08
L5	1	4 and 1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:08
L6	15058	324/754-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:08
L7	195	L6 and 1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:08
L8	1	7 and 4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:09
L9	63	probe and tri\$4 adj cable	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:09
L10	93	shielde\$4 adj probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:12

L11	440	shield\$4 adj2 chassis	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:12
L12	2	10 and 11	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:12
L13	35	tri adj2 axial adj cable	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:13
L14	3	guard adj layer with potential with conductor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:14
L15	127	ground\$4 with 11	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:14
L16	1	14 and 15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:41
L17	1	((shield\$4 adj2 probe with shield\$4 adj2 chassis) and tri adj2 axial adj2 cable with ground and potential)". "clm."	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/15 13:43
S1	3	(shielded adj probe) near5 test\$4 near4 (semiconductor or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 15:35
S2	98	probe with tri\$5 adj cable	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 14:47
S3	14350	324/754-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 14:48

S4	66	S2 and S3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 14:48
S5	5	(shielded adj probe) near5 test\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 15:35
S6	18	(shielded adj probe) and test\$4 near4 (semiconductor or integrated adj circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:28
S7	198	probe and tri\$5 adj cable	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:29
S8	14350	324/754-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 17:29
S9	86	S7 and S8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/17 19:00
S10	56	((("3787768") or ("3963986") or ("4480223") or ("4667523") or ("4731577") or ("4845426") or ("5003254") or ("5015947") or ("5150040") or ("5151653") or ("5168218") or ("5192907") or ("5325052") or ("5473254") or ("5488292") or ("5525911") or ("5729150") or ("5742174") or ("5952843") or ("6050829") or ("6075376") or ("6124723") or ("6137302") or ("6201402") or ("6276956") or ("6275051") or ("6586954") or ("6603322"))).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/02/17 19:04